

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re PATENT APPLICATION of:

Robert L. FRANCH et al.

Appln. No: 10/824,297

Art Unit: 2859

Filed: APRIL 14, 2004

Examiner: Gail VERBITSKY

For: ON CHIP TEMPERATURE MEASURING
AND MONITORING CIRCUIT
AND METHOD

AMENDMENT AFTER FINAL

Mail Stop **AF**
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir,

Responsive to a final Office action dated January 3, 2007, the applicants request amendment of the above identified application as follows:

Amendments to the Claims begin on page 2 of this amendment.

Remarks begin on page 8 of this amendment.